Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/669,527	FUJIKAWA ET AL.	
Examiner	Art Unit	
 Stephen J. Cherry	2863	

	SEARCHED				
Class	Subclass	Date	Examiner		
702	108 109 182 183				
	186				
717	186		:		
	131				
714	736				

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
:			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Consult Wei Zhen AJ 2191	6-20-2003	\$.c ,	
M. Nghiem AU 2863	6-20-05	S. C,	
See Eist Sech	6-21-05	, ے, ک	